

**D45VM Series**

File Number 2357

T-37-15

**Silicon P-N-P Transistors**

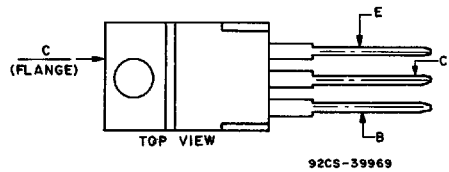
Complementary to the D44VM Series

**Features:**

- Very Fast Switching  $t_s \leq 500$  ns resistive  
 $t_f \leq 75$  ns
- Very low  $V_{CE(sat)} \leq 0.4V @ I_C = 4A$
- High gain  $H_{FE} \geq 40 @ I_C = 4A$

The D45VM-series of silicon p-n-p power transistors are especially designed for use in switching circuits such as switching regulators, high-frequency inverters/converters, and other applications where very fast switching times and low-saturation voltages are necessary. These devices are tested for parameters that relate directly to the design of high-power switching circuits. Switching times, saturation voltages, and leakage currents are specified at 100°C to provide information necessary for worst-case design..

**TERMINAL DESIGNATIONS**



JEDËC TO-220AB

**MAXIMUM RATINGS (T<sub>A</sub> = 25° C) (unless otherwise specified)**

RATING	SYMBOL	D45VM1	D45VM4	D45VM7	D45VM10	UNIT
Collector-Emitter Voltage	V <sub>CEO(sus)</sub>	-30	-45	-60	-80	V
Collector-Emitter Voltage	V <sub>CEX</sub>	-30	-45	-60	-80	V
Collector-Emitter Voltage	V <sub>CEV</sub>	-50	-70	-80	-100	V
Emitter Base Voltage	V <sub>EBO</sub>			-7		V
Collector Current — Continuous	I <sub>C</sub>			-8		A
— Peak (1)	I <sub>CM</sub>			-20		A
Base Current — Continuous	I <sub>B</sub>			-2		A
— Peak (1)	I <sub>BM</sub>			-5		A
Total Power Dissipation @ T <sub>C</sub> = 25°C	P <sub>D</sub>			50		Watts
Derate above 25°C				20		W/°C
@ T <sub>C</sub> = 100°C				0.4		
Operating and Storage Junction Temperature Range	T <sub>J</sub> , T <sub>STG</sub>			-55 to +150		°C

**THERMAL CHARACTERISTICS**

CHARACTERISTICS	SYMBOL	MAX	UNIT
Thermal Resistance, Junction to Case	R <sub>θJC</sub>	2.5	°C/W
Thermal Resistance, Junction to Ambient	R <sub>θJA</sub>	74	°C/W
Maximum Lead Temperature for Soldering Purposes: 1/8" from Case for 5 Seconds	T <sub>L</sub>	235	°C

(1) Pulse measurement condition PW ≤ 6.0 ms.

ELECTRICAL CHARACTERISTICS ( $T_C = 25^\circ\text{C}$ ) (unless otherwise specified)

CHARACTERISTICS	SYMBOL	MIN	MAX	UNIT
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OFF CHARACTERISTICS<sup>(1)</sup>

Collector-Emitter Sustaining Voltage <sup>(1)</sup> ( $I_C = -100\text{mA}$ , $I_B = 0$ ) D45VM1 D45VM4 D45VM7 D45VM10	$V_{CEO(sus)}$	-30 -45 -60 -80	— — — —	V
Collector-Emitter Voltage <sup>(2)</sup> ( $I_C = -3\text{A}$ , $V_{CLAMP} = \text{Rated } V_{CEX}$ , $T_C \leq 100^\circ\text{C}$ ) D45VM1 D45VM4 D45VM7 D45VM10	$V_{CEX}$	-30 -45 -60 -80	— — — —	V
Collector Cutoff Current ( $V_{CEV} = \text{Rated Value}$ , $V_{BE(off)} = 4.0\text{V}$ ) ( $V_{CEV} = \text{Rated Value}$ , $V_{BE(off)} = 4.0\text{V}$ , $T_C = 100^\circ\text{C}$ )	$I_{CEV}$	— —	-10 -100	$\mu\text{A}$
Collector Cutoff Current ( $V_{CE} = \text{Rated } V_{CEV}$ , $R_{BE} = 50 \Omega$ , $T_C = 100^\circ\text{C}$ )	$I_{CER}$	—	-100	$\mu\text{A}$
Emitter Cutoff Current ( $V_{EB} = -7\text{V}$ , $I_C = 0$ )	$I_{EBO}$	—	-10	$\mu\text{A}$

## SECOND BREAKDOWN

Second Breakdown with Base Forward Biased	$F_{BSOA}$	SEE FIGURE 7
Second Breakdown with Base Reverse Biased	$R_{BSOA}$	SEE FIGURE 8

ON CHARACTERISTICS<sup>(1)</sup>

DC Current Gain ( $I_C = -4\text{A}$ , $V_{CE} = -1\text{V}$ ) ( $I_C = -6\text{A}$ , $V_{CE} = -1\text{V}$ )	$h_{FE}$	40 20	— —	—
Collector-Emitter Saturation Voltage ( $I_C = -4\text{A}$ , $I_B = -0.2\text{A}$ ) ( $I_C = -6\text{A}$ , $I_B = -0.3\text{A}$ ) ( $I_C = -8\text{A}$ , $I_B = -0.8\text{A}$ , $T_C = 100^\circ\text{C}$ )	$V_{CE(sat)}$	— — —	-0.4 -0.6 -1.0	V
Base-Emitter Saturation Voltage ( $I_C = -4\text{A}$ , $I_B = -0.2\text{A}$ ) ( $I_C = -4\text{A}$ , $I_B = -0.2\text{A}$ , $T_C = 100^\circ\text{C}$ )	$V_{BE(sat)}$	— —	-1.2 -1.2	V

## DYNAMIC CHARACTERISTICS

Typical

Current-Gain — Bandwidth Product ( $I_C = -0.1\text{A}$ , $V_{CE} = -10\text{V}$ , $f_{test} = 1\text{ MHz}$ )	$f_T$	50	MHz
Output Capacitance ( $V_{CB} = -10\text{V}$ , $I_E = 0$ , $f_{test} = 1\text{ MHz}$ )	$C_{OB}$	70	PF

## SWITCHING CHARACTERISTICS

Maximum

Resistive Load (See Figure 16 for Test Circuit)		$T_C$	$25^\circ\text{C}$	$100^\circ\text{C}$	
Delay Time	$V_{CC} = 30\text{V}$ , $I_C = -6\text{A}$ $I_{B1} = I_{B2} = 0.6\text{A}$ $t_p = 25 \mu\text{sec}$	$t_d$	30	40	nsec
Rise Time		$t_r$	250	350	nsec
Storage Time		$t_s$	500	600	nsec
Fall Time		$t_f$	75	250	nsec
Inductive Load, Clamped (See Figure 15 for Test Circuit)					
Storage Time	$V_{CE(CLAMP)} = 30\text{V}$ , $I_C = -6\text{A}$ $I_{B1} = I_{B2} = 0.6\text{A}$ , $V_{BE(OFF)} = 5\text{V}$	$t_s$	500	600	nsec
Fall Time		$t_f$	70	100	nsec
		Typical			
Storage Time	$L = 200 \mu\text{H}$	$t_s$	340	430	nsec
Fall Time		$t_f$	40	57	nsec

(1) Pulse Duration = 300  $\mu\text{sec}$ , Duty Factor  $\leq 2\%$ 

(2) See Figure 15 for Test Circuit.

**D45VM Series**

TYPICAL DC CHARACTERISTICS

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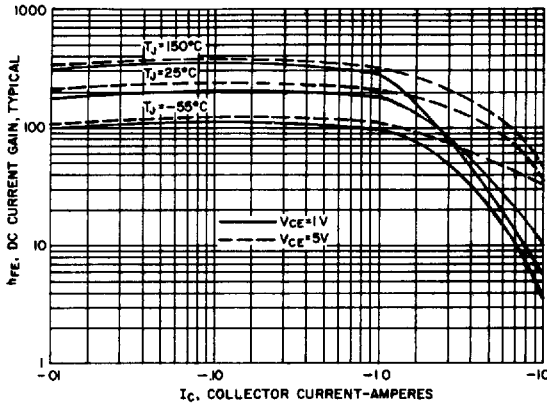


FIGURE 1. DC CURRENT GAIN

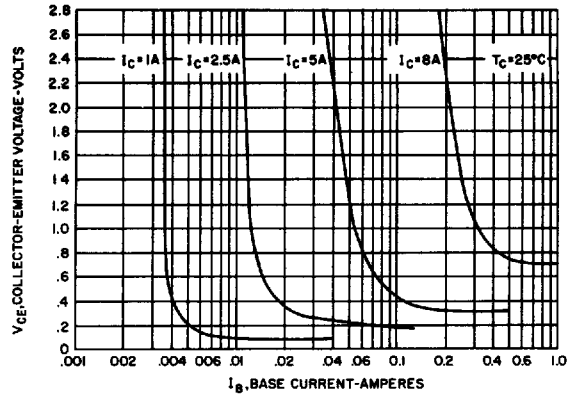


FIGURE 2. COLLECTOR SATURATION REGION

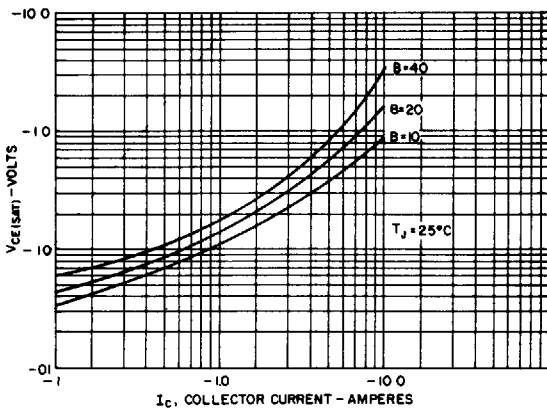


FIGURE 3.  $V_{CE(SAT)}$  VS.  $I_C$

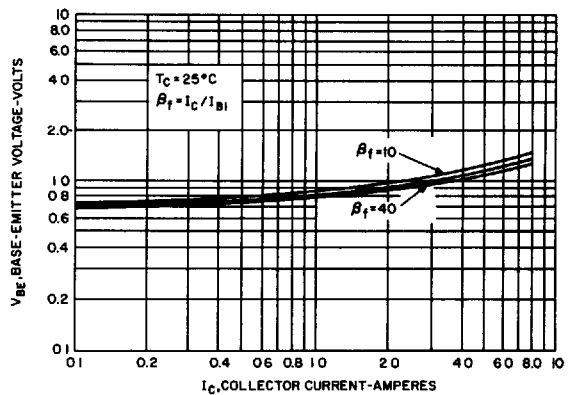


FIGURE 4.  $V_{BE(SAT)}$  VS.  $I_C$

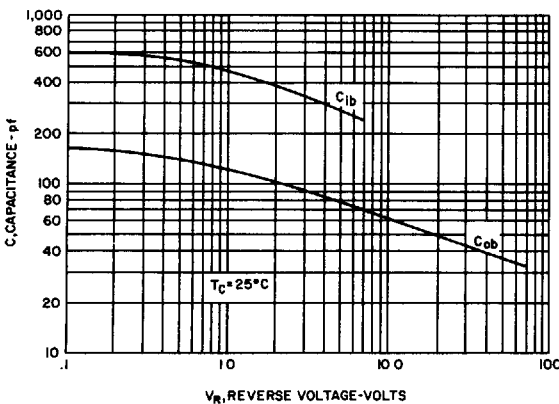


FIGURE 5. CAPACITANCE

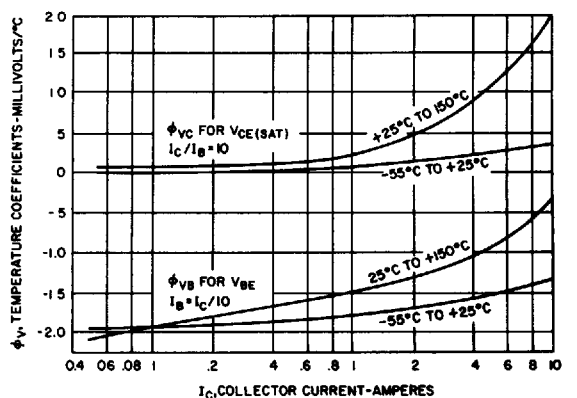


FIGURE 6. SATURATION VOLTAGE TEMPERATURE COEFFICIENTS

SAFE OPERATING AREA

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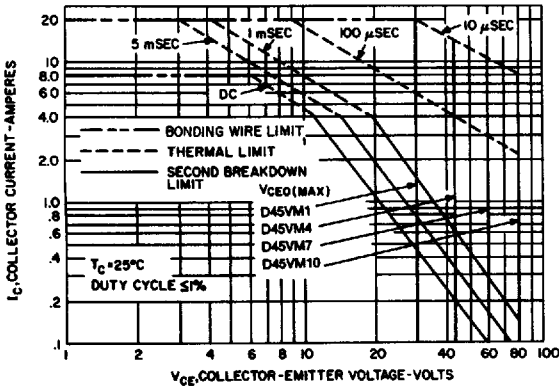


FIGURE 7. FORWARD BIAS SOA

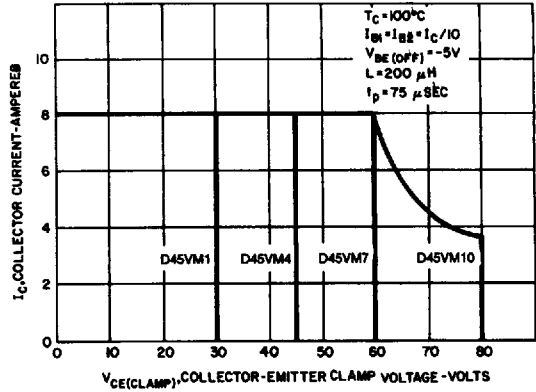


FIGURE 8. CLAMPED REVERSE BIAS SOA

TYPICAL SWITCHING CHARACTERISTICS

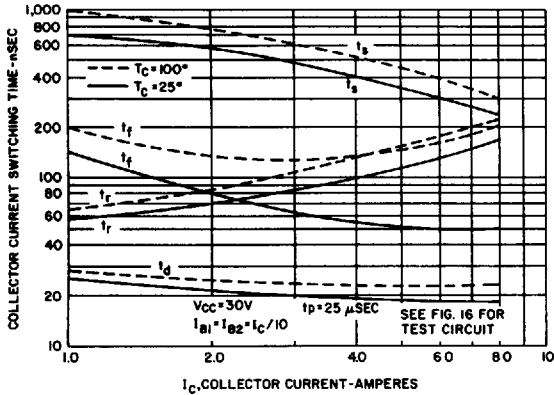


FIGURE 9. RESISTIVE SWITCHING TIME

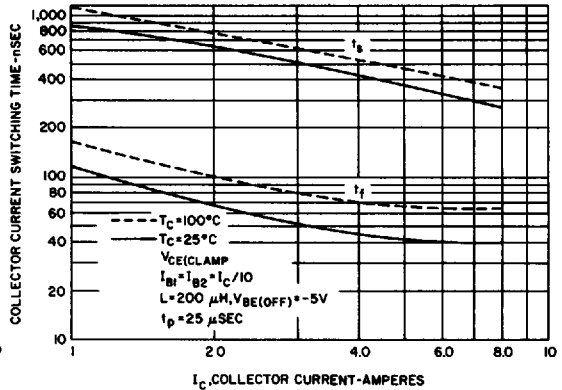


FIGURE 10. CLAMP INDUCTIVE TURN-OFF TIME

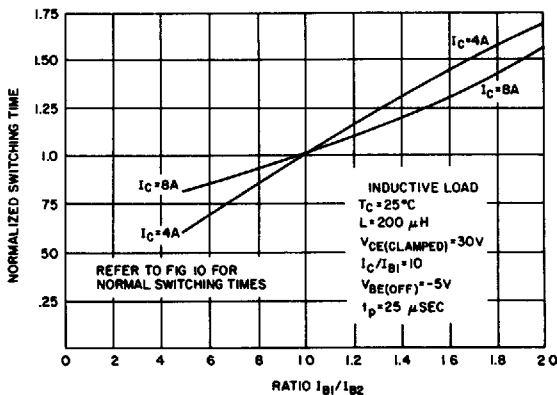


FIGURE 11. STORAGE TIME VARIATION WITH  $I_{B2}$

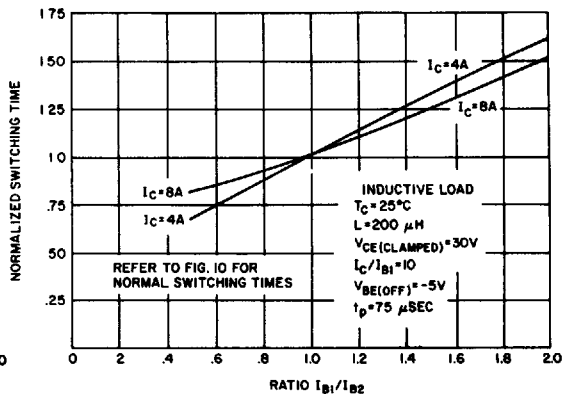


FIGURE 12. FALL TIME VARIATION WITH  $I_{B2}$

POWER TRANSISTORS

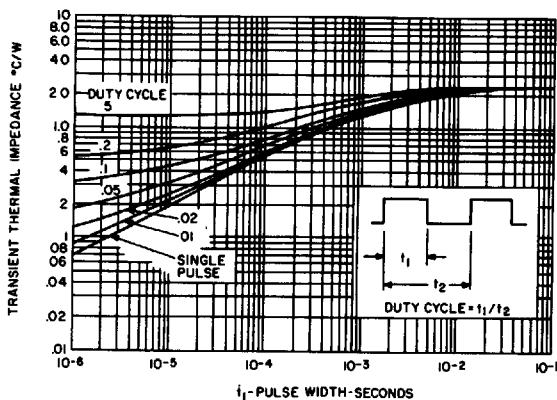


FIGURE 13. TRANSIENT THERMAL RESPONSE

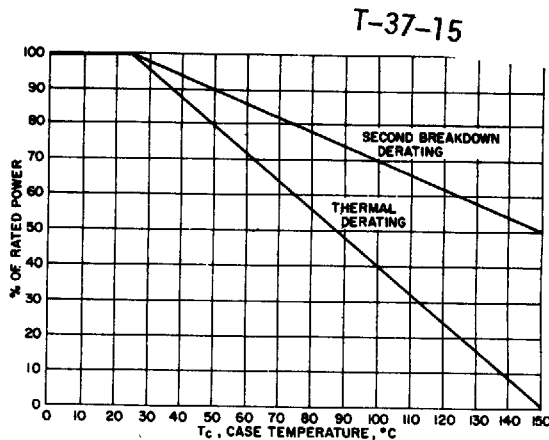
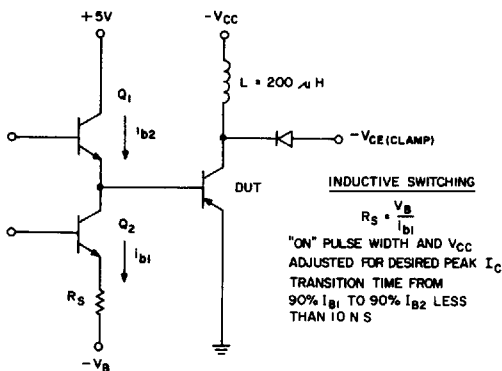
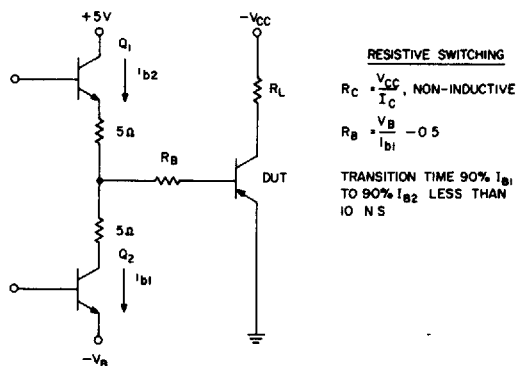


FIGURE 14. POWER DERATING FACTOR



15. INDUCTIVE SWITCHING AND  $V_{CEX}$

**TEST CIRCUITS**



16. RESISTIVE SWITCHING